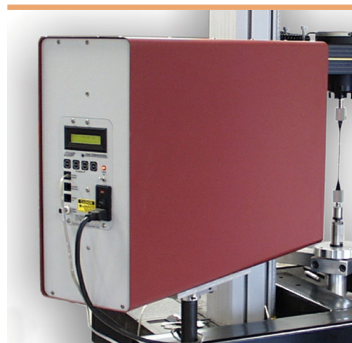


These extensometers are high precision non-contacting units for strain measurement in materials testing. They use a high speed laser scanner to measure the spacing between reflective tape strips on the sample. The measurement range is from 8 to 127 mm (0.3 to 5 inches). The gauge length is determined by the user. This allows high elongation measurements when shorter gauge lengths are used.



Model LE-05 laser extensometer control panel



Laser extensometer

Model LE-05 laser extensometers measure strain optically, without contacting the specimen, using laser diode technology. The extensometers are self-contained and portable. They may be interfaced with a variety of testing machines and data acquisition systems using the $\pm 10V$ analog output or bi-directional RS-232 serial port. Operation may be local or remote. A digital display is included.

The scanning beam is always perpendicular to the specimen, unlike most laser extensometers. This eliminates errors when viewing through windows in chambers. It also minimizes sensitivity to the distance between the extensometer and the sample. Because the unit measures reflected light, no receiver is required behind the sample.

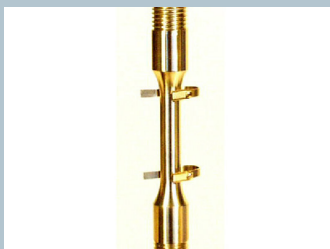
For non-contacting measurement applications requiring higher resolution or higher data rates, see the Epsilon ONE.

Easy to use.

The visible laser light is simply aimed at the specimen, which has small reflective tape strips set at the gauge length desired. The extensometer displays the actual measured gauge length. If desired, the zero button will offset the output to zero. As the specimen is tested, the display will then read the elongation directly.

The analog output and RS-232 interface are easily connected to existing controls or data acquisition systems.

The reflective tape can be used at temperatures up to 80 °C (180 °F). High temperature clip-on reflectors may be used as an alternate to tape reflectors. These are re-usable and available as an option. They are rated for use to 425 °C (800 °F).



Laser extensometer high temperature clip-on reflectors

Features

- Non-contacting optical design requires only reflective tape marks on the specimen, or clip-on reflectors
- Ideal for use in chambers - calibration not affected by aiming through viewing windows
- High resolution of 1 micron
- 127 mm (5 inch) measuring range allows high elongation measurements

SPECIFICATIONS

Model LE-05

<i>Measurement Range:</i>	8 to 127 mm (0.3 to 5 inches))
<i>Max. Resolution:</i>	0.001 mm (0.0001 inches)
<i>Linearity ¹:</i>	±0.01 mm (±0.0004 inches)
<i>Repeatability ¹:</i>	±0.005 mm (±0.0002 inches)
<i>Max. Scan Rate:</i>	100 scans/second
<i>Target Distance:</i>	250 mm nominal, 500 mm max., selectable 10 inches nominal, 20 inches max., selectable
<i>Zero Suppression:</i>	Reading may be set to zero anywhere in measuring range
<i>Scan Line Orientation:</i>	Vertical
<i>Scan Averaging:</i>	Moving window averaging over a selectable number of scans
<i>Analog Output:</i>	16 bit, ±10 VDC standard
<i>Full Scale Ranges:</i>	2.0, 5.0, 10, 20, 50, or 100 mm 0.1, 0.2, 0.5, 1.0, 2.0, or 5.0 inches
<i>Digital Communications:</i>	RS-232 serial communications, standard 3 wire
<i>Selectable Baud Rate:</i>	9600, 4800, 2400, or 1200
<i>Display:</i>	2 line, 16 character digital display, backlit LCD
<i>Power Input:</i>	115 VAC ±10%, 50/60 Hz standard 230 VAC ±10%, 50/60 Hz optional
<i>Size:</i>	381 L x 180 H x 114 W mm (15 L x 7.1 H x 4.5 W inches)
<i>Weight:</i>	6 kg (13 lbs.)
<i>Mounting Provisions:</i>	1/4-20 UNC tapped holes in base (4)
<i>Laser Source:</i>	Diode laser, 670 nm, <1 mW maximum scanned output CDRH Certified Class II laser instrument
<i>Options:</i>	Consult factory for options like reflective clips for high temperature use

¹ Over optimum displacement range at calibrated distance
Note: Specifications measured at 25 °C and 50% relative humidity.

Visit our website at www.epsilontech.com
Contact us for your special testing requirements.

